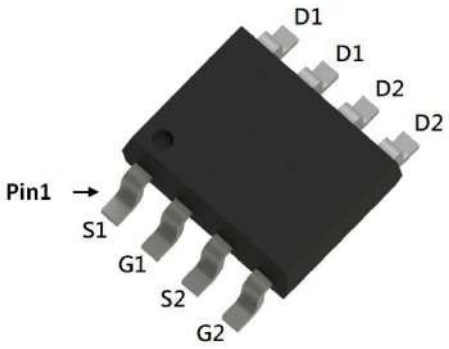
Dual N-Channel Enhancement Mode Power MOSFET

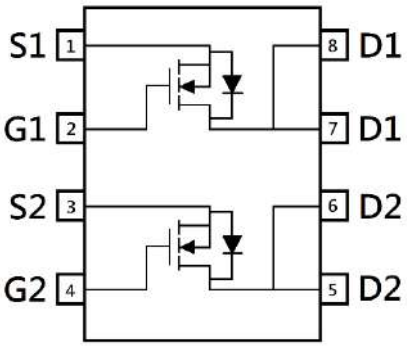
Features:

- Low On Resistance
- Low Gate Charge
- Fast Switching Characteristic

SOP-8



BV_{DSS}	100V
I_D@V_{GS}=10V, T_C=25°C	6.6A
I_D@V_{GS}=10V, T_A=25°C	3A
$R_{DS(ON)typ.}$@V_{GS}=10V, I_D=2A	80mΩ



G : Gate S : Source D : Drain

Ordering Information

Device	Package	Shipping
KSCE080A10	SOP-8 (Pb-free lead plating and halogen-free package)	4000 pcs / Tape & Reel

Absolute Maximum Ratings (T_A=25°C)

Parameter		Symbol	Limits	Unit
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	±20	
Continuous Drain Current @ V_{GS}=10V, T_C=25°C	*a	I_D	6.6	A
Continuous Drain Current @ V_{GS}=10V, T_C=100°C	*a		4.2	
Continuous Drain Current @ V_{GS}=10V, T_A=25°C	*b		3	
Continuous Drain Current @ V_{GS}=10V, T_A=70°C	*b		2.4	
Pulsed Drain Current	*c	I_{DM}	26	
Continuous Body Diode Forward Current @ T_C=25°C	*a	I_S	6.6	
Pulsed Body Diode Forward Current @ T_C=25°C	*a	I_{SM}	26	
Avalanche Current @ L=0.1mH		I_{AS}	10	
Avalanche Energy @ L=0.5mH		E_{AS}	12	mJ
Total Power Dissipation	T_C=25℃ *a	P_D	9.6	W
	T_C=100℃ *a		3.8	
	T_A=25°C *b		2	
	T_A=70°C *b		1.3	
Operating Junction and Storage Temperature Range		T_J, T_{stg}	-55~+150	°C

Thermal Data

Parameter		Symbol	Steady State	Unit
Thermal Resistance, Junction-to-case		$R_{\theta JC}$	13	°C/W
Thermal Resistance, Junction-to-ambient	*b	$R_{\theta JA}$	62	

Note:

*a. The power dissipation P_D is based on $T_{J(MAX)}$=150℃, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

*b. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in^2 FR -4 board with 2 oz. copper, in a still air environment with T_A=25℃. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150℃. The value in any given application depends on the user's specific board design.

*c. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$=150℃. Ratings are based on low frequency and low duty cycles to keep initial T_J=25℃.

Electrical Characteristics (T_A=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	100	-	-	V	V_{GS}=0V, I_D=250μA
$V_{GS(th)}$	2	-	4		V_{DS}=V_{GS}, I_D=250μA
G_{FS}	-	3.7	-	S	V_{DS}=10V, I_D=2A
I_{GSS}	-	-	±100	nA	V_{GS}=±20V, V_{DS}=0V
I_{DSS}	-	-	1	μA	V_{DS}=80V, V_{GS}=0V
$R_{DS(ON)}$	-	80	105	mΩ	V_{GS}=10V, I_D=2A
Dynamic					
Ciss	-	305	-	pF	V_{DS}=50V, V_{GS}=0V, f=1MHz
Coss	-	35	-		
Crss	-	17	-		
Rg	-	2.8	-	Ω	f=1MHz
Qg *1, 2	-	7	-	nC	V_{DS}=50V, I_D=3A, V_{GS}=10V
Qgs *1, 2	-	1.8	-		
Qgd *1, 2	-	2	-		
$t_{d(ON)}$ *1, 2	-	7	-	ns	V_{DS}=50V, I_D=3A, V_{GS}=10V, R_{GS}=1Ω
tr *1, 2	-	16	-		
$t_{d(OFF)}$ *1, 2	-	15	-		
t_f *1, 2	-	7.6	-		
Source-Drain Diode					
V_{SD} *1	-	0.78	1.2	V	I_S=2A, V_{GS}=0V
trr	-	24	-	ns	I_F=3A, dI_F/dt=100A/μs
Qrr	-	28	-	nC	

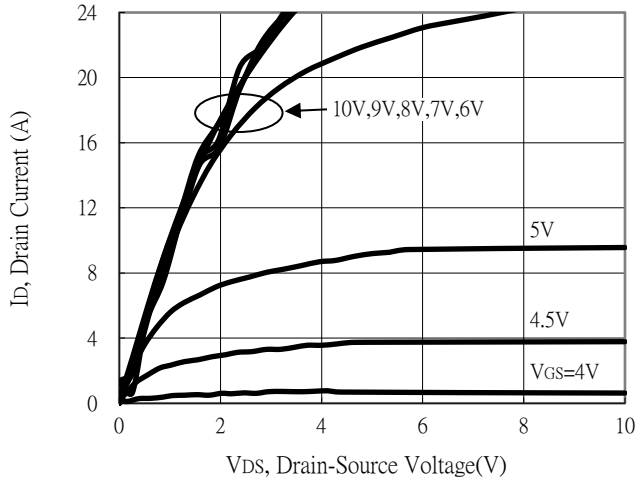
Note:

*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

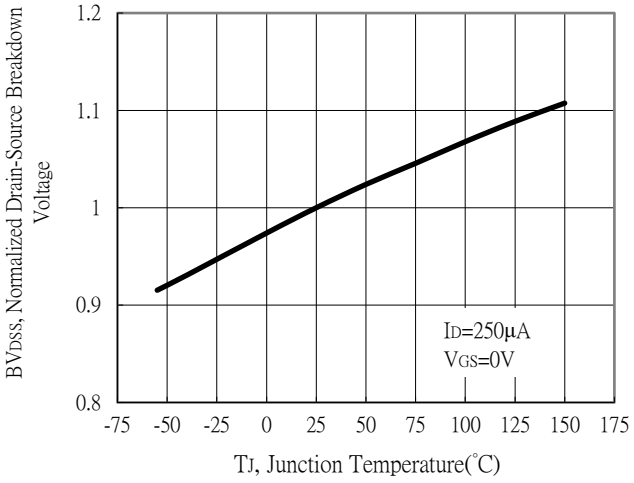
*2. Independent of operating temperature

Typical Characteristics

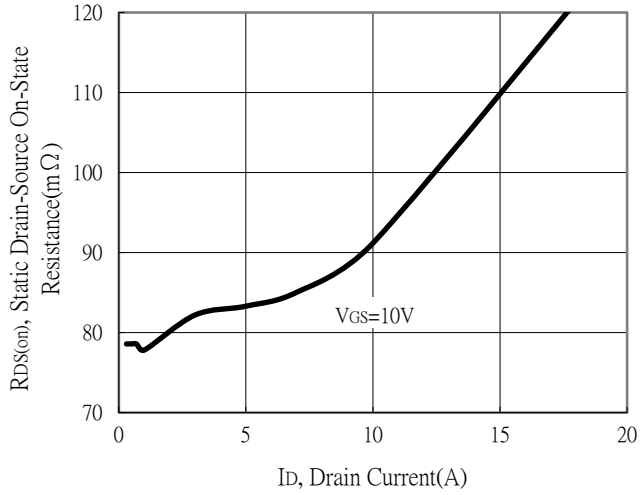
Typical Output Characteristics



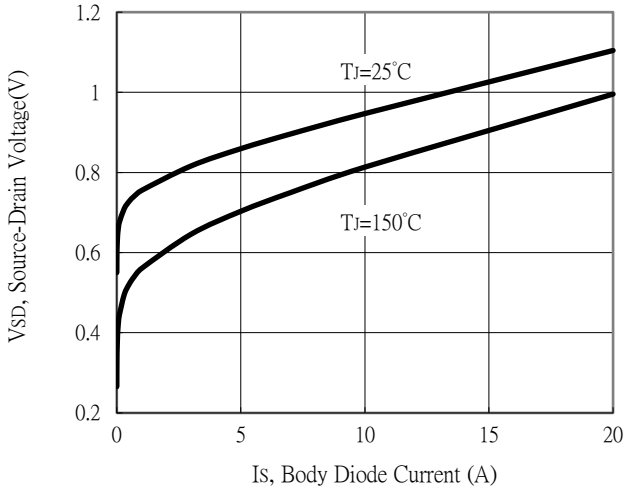
Breakdown Voltage vs Ambient Temperature



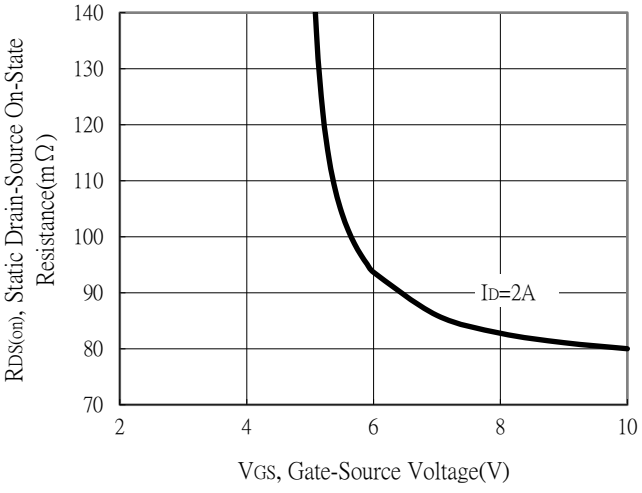
Static Drain-Source On-State resistance vs Drain Current



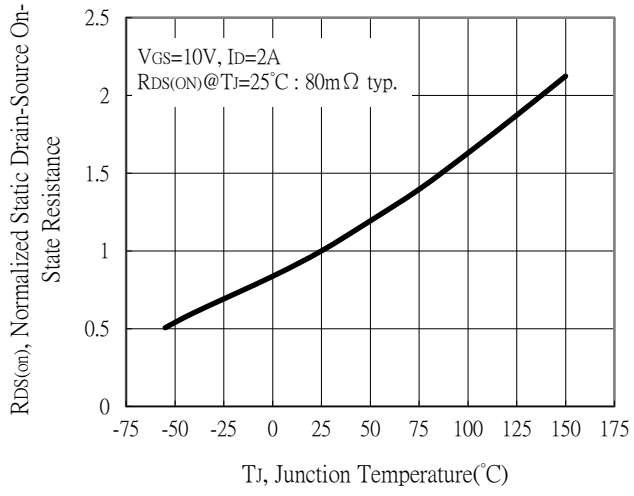
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

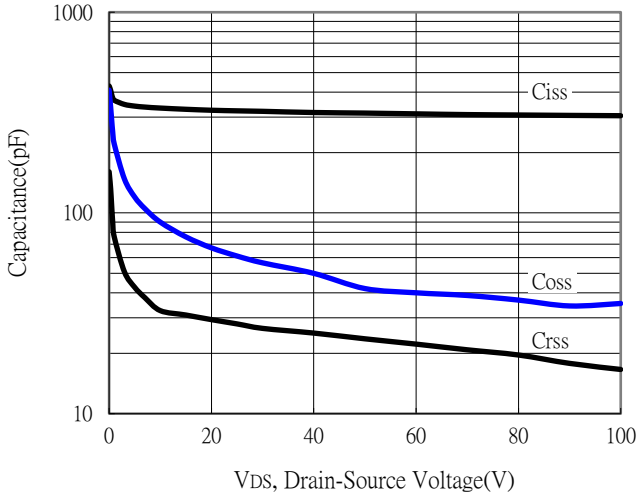


Drain-Source On-State Resistance vs Junction Temperature

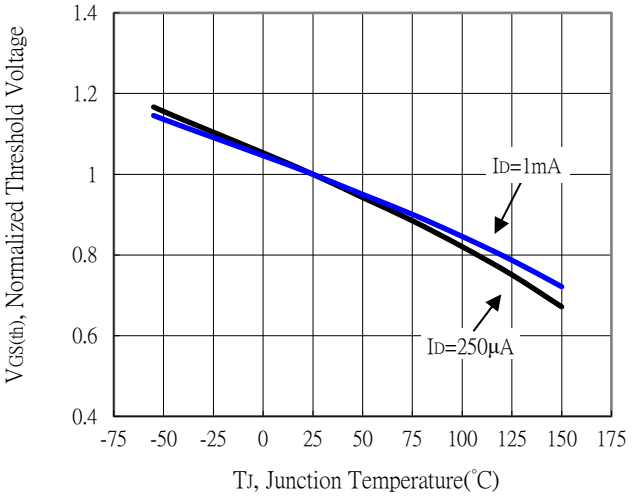


Typical Characteristics (Cont.)

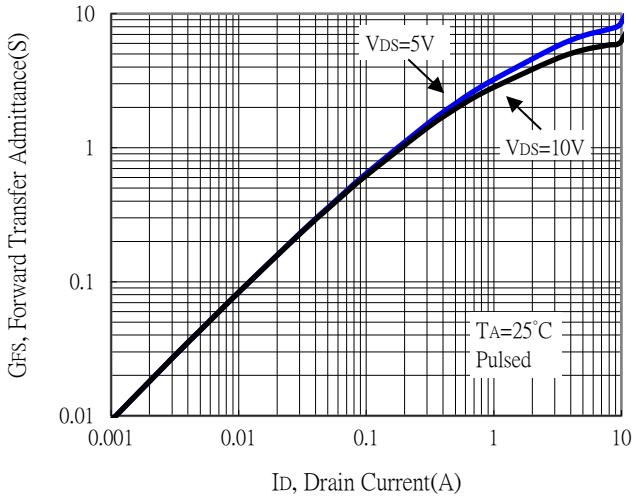
Capacitance vs Drain-to-Source Voltage



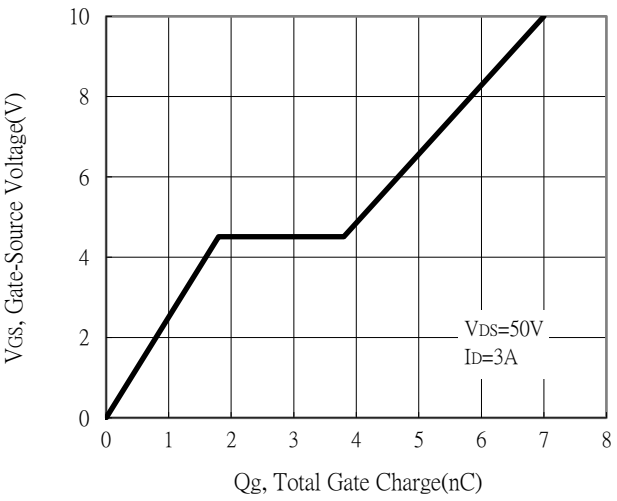
Threshold Voltage vs Junction Temperature



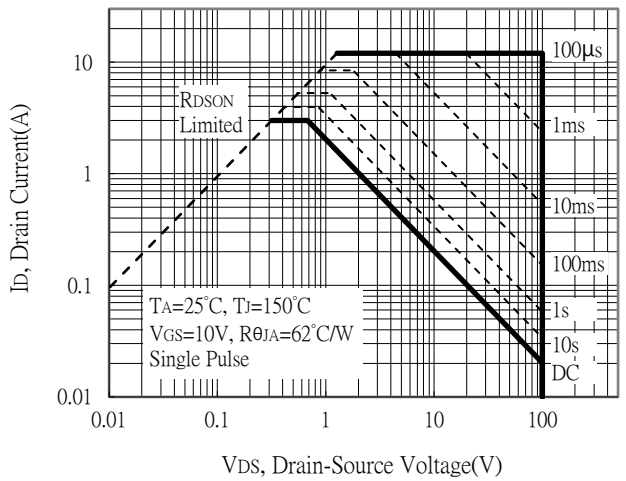
Forward Transfer Admittance vs Drain Current



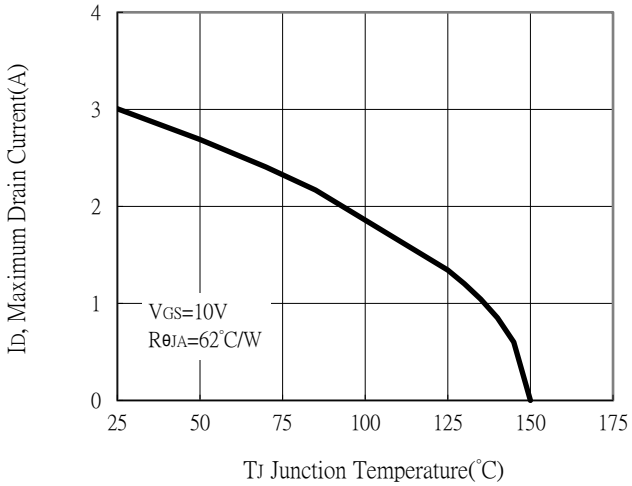
Gate Charge Characteristics



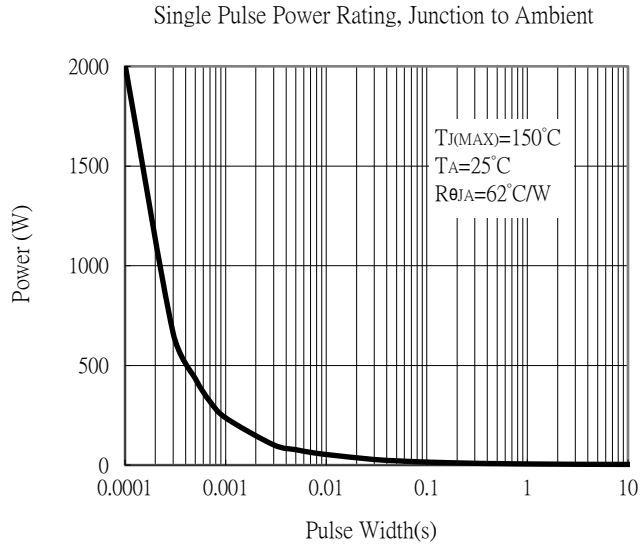
Maximum Safe Operating Area

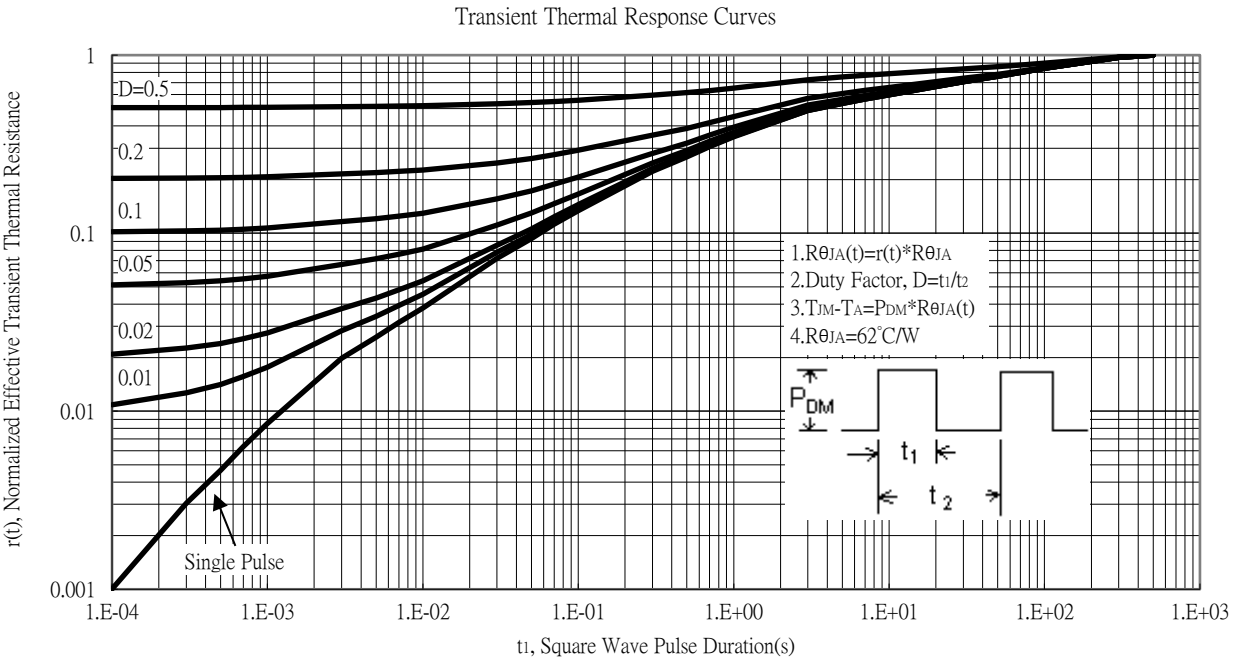


Maximum Drain Current vs Junction Temperature

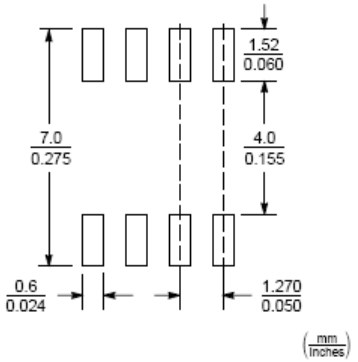


Typical Characteristics (Cont.)

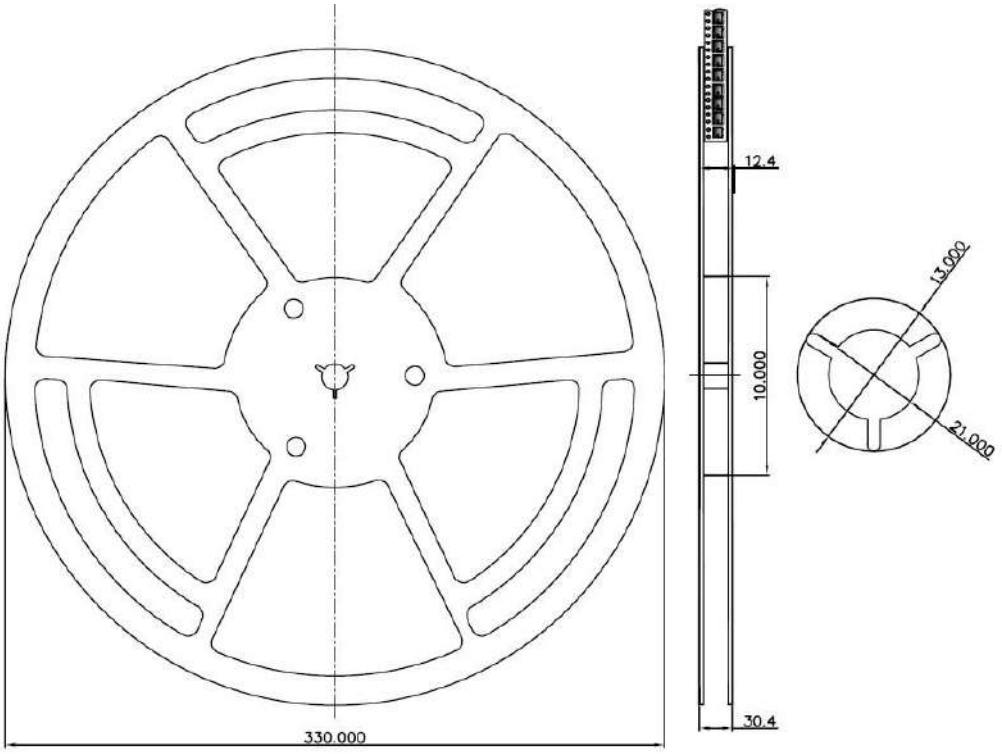




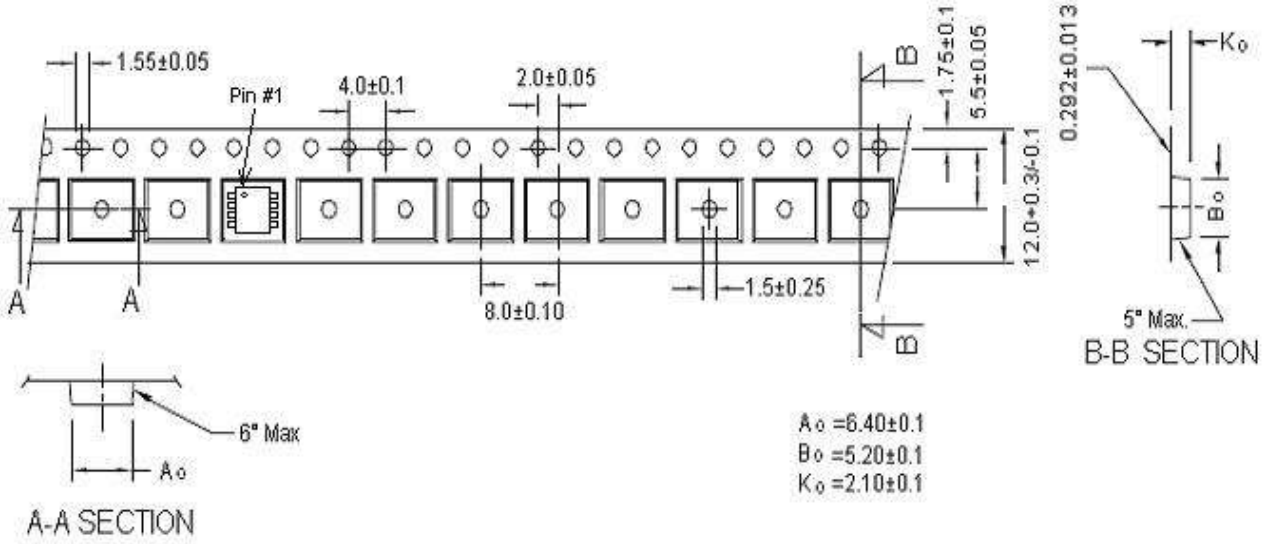
Recommended Soldering Footprint



Reel Dimension



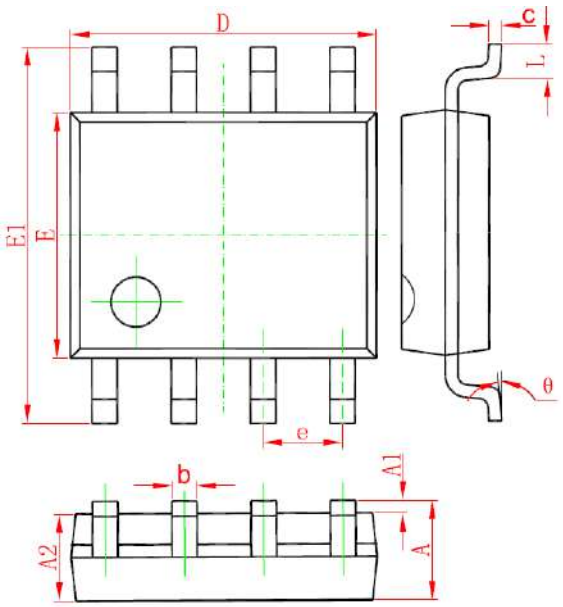
Carrier Tape Dimension



Notes:
1. 10 sprocket hole pitch cumulative tolerance ±0.2.
2. Camber not to exceed 1mm in 100mm.
3. Material: conductive black polystyrene
4. Ao & Bo measured on a plane 0.3mm above the bottom of the pocket.
5. Ko measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

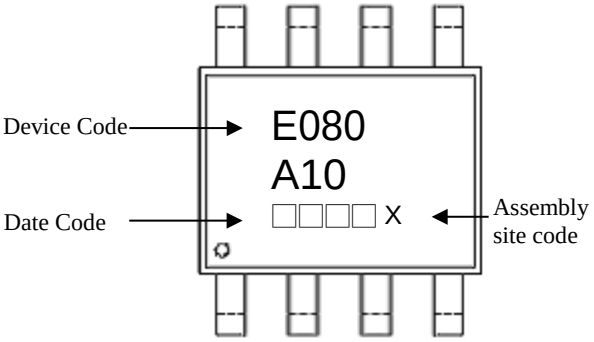
Uni : millimeter

SOP-8 Dimension



8-Lead SOP-8 Plastic Package

Marking:



Date Code(counting from left to right) :
1st code: year code, the last digit of Christian year
2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D
May→E, Jun→F, Jul→G, Aug→H, Sep→J,
Oct→K, Nov→L, Dec→M
3rd and 4th codes : production serial number, 01~99

Assembly site code : blank→ site 1, G →site 2

*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.350	1.750	0.053	0.069	E	3.800	4.000	0.150	0.157
A1	0.100	0.250	0.004	0.010	E1	5.800	6.200	0.228	0.244
A2	1.350	1.550	0.053	0.061	e	*1.270		*0.050	
b	0.330	0.510	0.013	0.020	L	0.400	1.270	0.016	0.050
c	0.170	0.250	0.006	0.010	θ	0°	8°	0°	8°
D	4.700	5.100	0.185	0.200					